Search Notes



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Fotakis, Aristocratis

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SEARCHED

Class	Subclass	Date	Examiner
375	322, 345, 346, 317, 319	09/22/2007	AF
370	201	09/22/2007	AF

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Chieh M.Fan	5/24/2007	AF
Consulted with Chieh M.Fan	09/20/2007	AF
EAST, IEEE, EPO, Internet Search	09/22/2007	AF
Inventors Name Search foir Double Patenting	09/22/2007	AF

INTERFERENCE SEARCH

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375	322, 345, 346, 317, 319	09/22/2007	AF
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